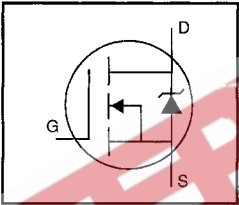


HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

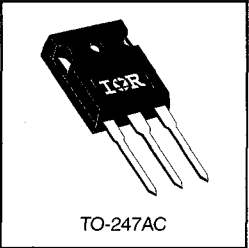


|                            |
|----------------------------|
| $V_{DSS} = 250V$           |
| $R_{DS(on)} = 0.075\Omega$ |
| $I_D = 38A$                |

Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.



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Absolute Maximum Ratings

|                           | Parameter                                 | Max.                  | Units |
|---------------------------|-------------------------------------------|-----------------------|-------|
| $I_D @ T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10 V$ | 38                    | A     |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10 V$ | 24                    |       |
| $I_{DM}$                  | Pulsed Drain Current ①                    | 150                   |       |
| $P_D @ T_C = 25^\circ C$  | Power Dissipation                         | 280                   | W     |
|                           | Linear Derating Factor                    | 2.2                   | W/°C  |
| $V_{GS}$                  | Gate-to-Source Voltage                    | ±20                   | V     |
| $E_{AS}$                  | Single Pulse Avalanche Energy ②           | 1000                  | mJ    |
| $I_{AR}$                  | Avalanche Current ①                       | 38                    | A     |
| $E_{AR}$                  | Repetitive Avalanche Energy ①             | 28                    | mJ    |
| dv/dt                     | Peak Diode Recovery dv/dt ③               | 4.8                   | V/ns  |
| $T_J$                     | Operating Junction and                    | -55 to +150           | °C    |
| $T_{STG}$                 | Storage Temperature Range                 |                       |       |
|                           | Soldering Temperature, for 10 seconds     | 300 (1.6mm from case) |       |
|                           | Mounting Torque, 6-32 or M3 screw         | 10 lbf•in (1.1 N•m)   |       |

Thermal Resistance

|                 | Parameter                           | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | —    | 0.45 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | —    | 0.24 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | —    | 40   |       |

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## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

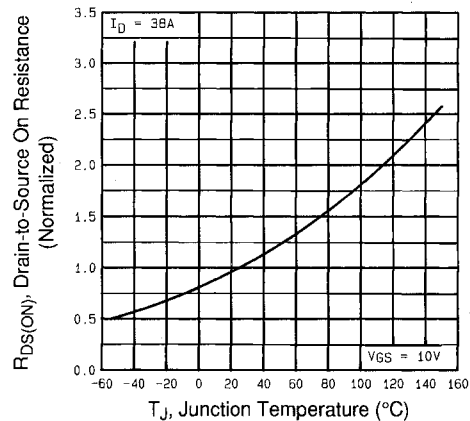
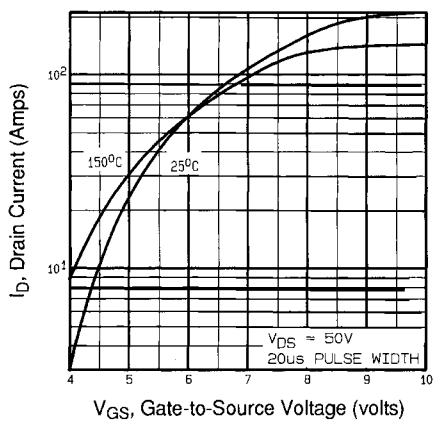
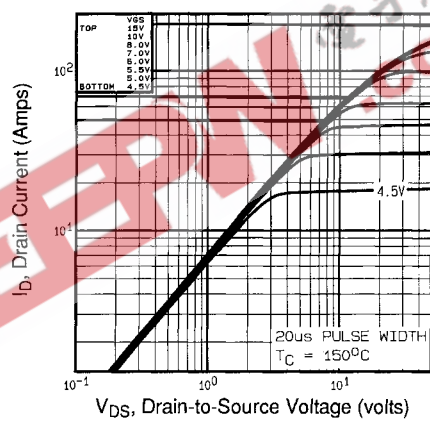
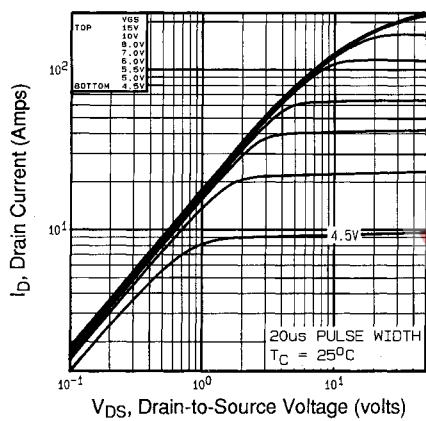
|                                 | Parameter                            | Min. | Typ. | Max.  | Units               | Test Conditions                                                     |
|---------------------------------|--------------------------------------|------|------|-------|---------------------|---------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 250  | —    | —     | V                   | $V_{GS}=0V$ , $I_D=250\mu A$                                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.37 | —     | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D=1mA$                         |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.075 | $\Omega$            | $V_{GS}=10V$ , $I_D=23A$ ③                                          |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0   | V                   | $V_{DS}=V_{GS}$ , $I_D=250\mu A$                                    |
| $g_{fs}$                        | Forward Transconductance             | 20   | —    | —     | S                   | $V_{DS}=50V$ , $I_D=23A$ ④                                          |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25    | $\mu A$             | $V_{DS}=250V$ , $V_{GS}=0V$                                         |
|                                 |                                      | —    | —    | 250   | $\mu A$             | $V_{DS}=200V$ , $V_{GS}=0V$ , $T_J=125^\circ\text{C}$               |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100   | nA                  | $V_{GS}=20V$                                                        |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100  | nA                  | $V_{GS}=-20V$                                                       |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 210   | nC                  | $I_D=38A$                                                           |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 35    | nC                  | $V_{DS}=200V$                                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 98    | nC                  | $V_{GS}=10V$ See Fig. 6 and 13 ④                                    |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 22   | —     | ns                  | $V_{DD}=125V$                                                       |
| $t_r$                           | Rise Time                            | —    | 99   | —     | ns                  | $I_D=38A$                                                           |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 110  | —     | ns                  | $R_G=4.3\Omega$                                                     |
| $t_f$                           | Fall Time                            | —    | 92   | —     | ns                  | $R_D=3.2\Omega$ See Figure 10 ④                                     |
| $L_D$                           | Internal Drain Inductance            | —    | 5.0  | —     | nH                  | Between lead, 6 mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 13   | —     | nH                  |                                                                     |
| $C_{iss}$                       | Input Capacitance                    | —    | 5400 | —     | pF                  | $V_{GS}=0V$                                                         |
| $C_{oss}$                       | Output Capacitance                   | —    | 870  | —     | pF                  | $V_{DS}=25V$                                                        |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 150  | —     | pF                  | $f=1.0MHz$ See Figure 5                                             |

## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min.                                                                      | Typ. | Max. | Units   | Test Conditions                                                                                                                                     |
|----------|----------------------------------------|---------------------------------------------------------------------------|------|------|---------|-----------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                         | —    | 38   | A       | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                         | —    | 150  | A       |                                                                                                                                                     |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                         | —    | 1.8  | V       | $T_J=25^\circ\text{C}$ , $I_S=38A$ , $V_{GS}=0V$ ④                                                                                                  |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                         | 410  | 620  | ns      | $T_J=25^\circ\text{C}$ , $I_F=38A$                                                                                                                  |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                         | 5.7  | 8.6  | $\mu C$ | $di/dt=100A/\mu s$ ④                                                                                                                                |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |         |                                                                                                                                                     |

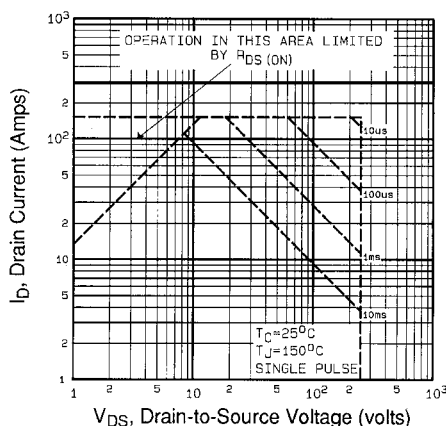
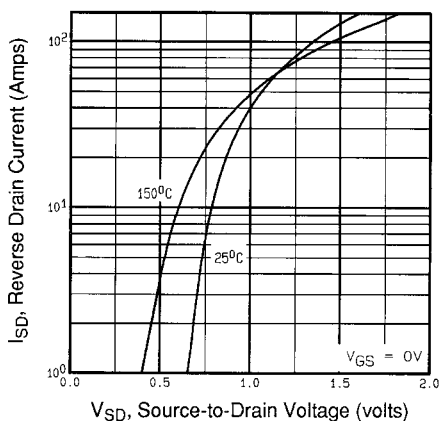
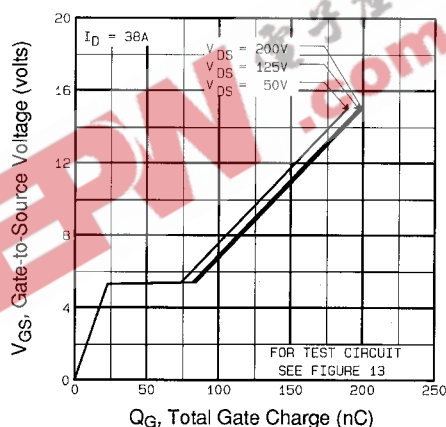
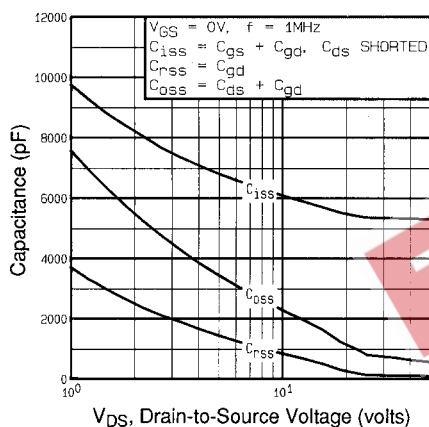
### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=50V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=1.1mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=38A$  (See Figure 12)
- ③  $I_{SD}\leq 38A$ ,  $di/dt\leq 210A/\mu s$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 150^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



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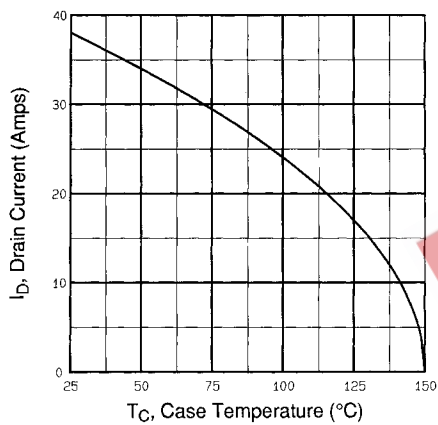


Fig 9. Maximum Drain Current Vs. Case Temperature

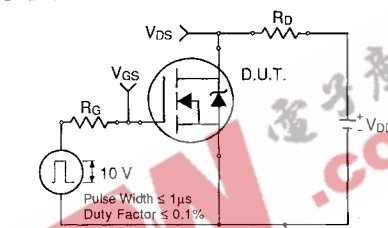


Fig 10a. Switching Time Test Circuit

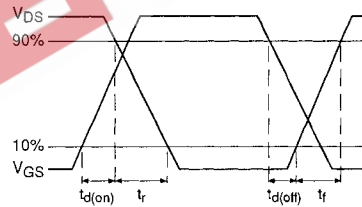


Fig 10b. Switching Time Waveforms

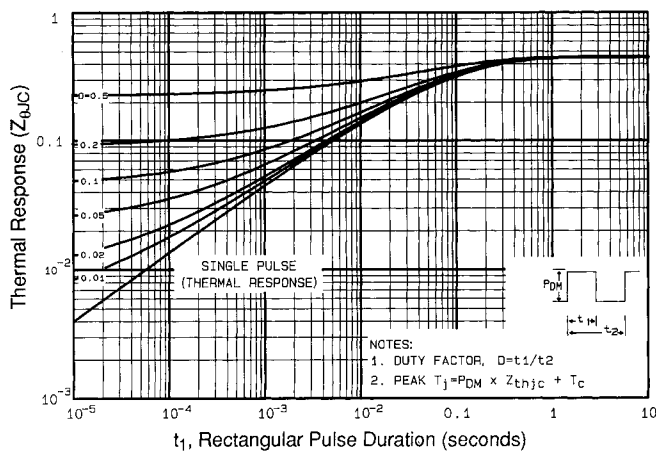


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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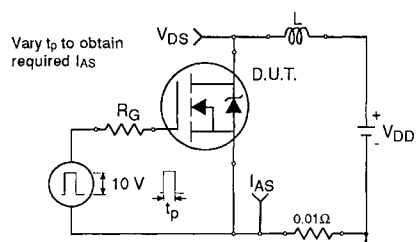


Fig 12a. Unclamped Inductive Test Circuit

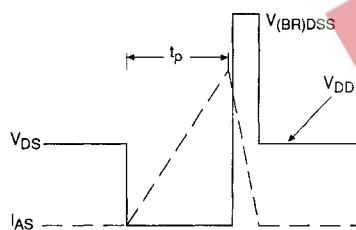


Fig 12b. Unclamped Inductive Waveforms

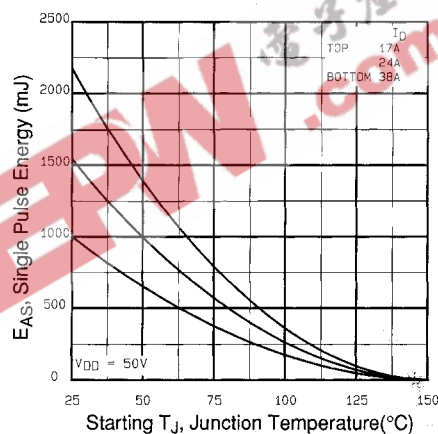


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

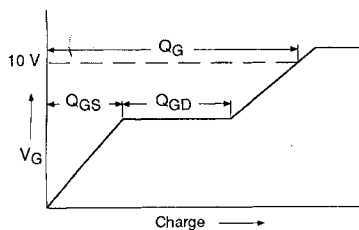


Fig 13a. Basic Gate Charge Waveform

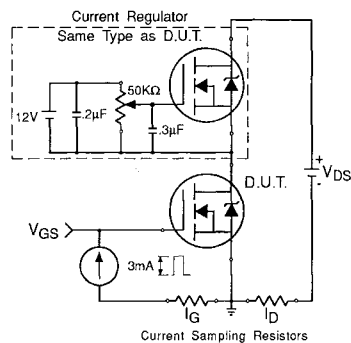


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery  $dv/dt$  Test Circuit – See page 1505

Appendix B: Package Outline Mechanical Drawing – See page 1511

Appendix C: Part Marking Information – See page 1517

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